# MOSFET - Power, Single N-Channel, PQFN8 5x6 150 V, 11.5 mΩ, 78 A

# NTMFS011N15MC

# **Features**

- Small Footprint (5 x 6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

## **Typical Applications**

- Synchronous Rectification
- AC-DC and DC-DC Power Supplies
- AC-DC Adapters (USB PD) SR
- Load Switch

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ , Unless otherwise specified)

Parameter			Symbol	Value	Unit
Drain-to-Source Breakdown Voltage			V <sub>(BR)DSS</sub>	150	V
Gate-to-Source Volta	ige		$V_{GS}$	±20	V
Continuous Drain Current $R_{\theta JC}$ (Note 2)	Steady State T <sub>C</sub> = 25°C		I <sub>D</sub>	78	Α
Power Dissipation R <sub>θJC</sub> (Note 2)			P <sub>D</sub>	147	W
Continuous Drain Current $R_{\theta JA}$ (Note 1, 2)	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	10.7	Α
Power Dissipation $R_{\theta JA}$ (Note 1, 2)			P <sub>D</sub>	2.7	W
Pulsed Drain Cur- rent	T <sub>A</sub> = 25°C, t <sub>p</sub> = 250 μs		I <sub>DM</sub>	259	Α
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>stg</sub>	–55 to +150	°C	
Source Current (Body Diode)			I <sub>S</sub>	133	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>AV</sub> = 39 A, L = 0.1 mH)			E <sub>AS</sub>	76.1	mJ
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)			TL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad size, 1 oz Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

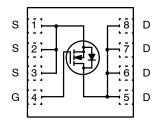


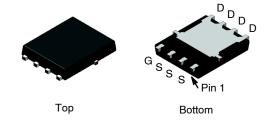
# ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
150 V	11.5 mΩ @ 10 V	35 A
	13.2 mΩ @ 8 V	18 A

#### **N-Channel MOSFET**





PQFN8 5x6 (Power 56) CASE 483AE

## **MARKING DIAGRAM**



A = Assembly Location

Y = Year W = Work

W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Max	Unit
$R_{ heta JC}$	Junction-to-Case - Steady State (Note 5)	0.85	°C/W
$R_{ hetaJA}$	Junction-to-Ambient - Steady State (Note 5)	46	

# **ORDERING INFORMATION**

Device	Device Marking	Package	Shipping (Qty / Packing) <sup>†</sup>
NTMFS011N15MC	NTMFS011N15MC	PQFN8 5x6 (Power 56) (Pb-Free/Halogen Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Condition	าร	Min	Тур	Max	Unit
OFF CHARAC	TERISTICS						
V <sub>(BR)DSS</sub>	Drain – to – Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 25$	60 μΑ	150			V
V <sub>(BR)DSS</sub> / T <sub>J</sub>	Drain – to – Source Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, ref to 25°C			85		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	T <sub>J</sub> = 25°C				1	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 120 \text{ V}$	T <sub>J</sub> = 125°C			100	
$I_{GSS}$	Gate – to – Source Leakage Current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 3	±20 V			±100	nA
ON CHARACT	ERISTICS (Note 3)						
V <sub>GS(TH)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 19$	94 μΑ	2.5	3.35	4.5	V
V <sub>GS(TH)</sub> / I <sub>J</sub>	Negative Threshold Temperature Coefficient	I <sub>D</sub> = 250 μA, ref to 25°C			-7.2		mV/°C
R <sub>DS(on)</sub>	Drain – to – Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3	35 A		9.0	11.5	mΩ
		V <sub>GS</sub> = 8 V, I <sub>D</sub> = 18 A			9.7	13.2	1
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 18 A			96	116	S
R <sub>G</sub>	Gate-Resistance	T <sub>A</sub> = 25°C			0.9	1.1	Ω
CHARGES & C	CAPACITANCES						
CISS	Input Capacitance	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 75 V			2478	3592	pF
Coss	Output Capacitance				728	1092	1
CRSS	Reverse Transfer Capacitance				7.9	15	1
Q <sub>G(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 8 V, V <sub>DS</sub> = 75 V,	I <sub>D</sub> = 35 A		30.6	46	nC
Q <sub>G(TOT)</sub>	Total Gate Charge				30.7	46	1
Q <sub>GS</sub>	Gate-to-Source Charge	.,	/ L 05 A		12.8		1
Q <sub>SW</sub>	Switching Charge	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 75 V	', I <sub>D</sub> = 35 A		9.4		1
Q <sub>GD</sub>	Gate-to-Drain Charge	V <sub>GS</sub> = 0 V, V <sub>DD</sub> = 75 V			4.5		1
Qoss	Output Charge				95		1
V <sub>GP</sub>	Plateau Voltage	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 75 V, I <sub>D</sub> = 35 A			5.1		V
SWITCHING C	HARACTERISTICS (Note 3)				-	-	•
t <sub>d(ON)</sub>	Turn – On Delay Time	$V_{GS}$ = 10 V, $V_{DS}$ = 75 V, $I_{D}$ = 35 A, $R_{G}$ = 6 $\Omega$			19.8		ns
t <sub>r</sub>	Rise Time				4.7		1
t <sub>d(OFF)</sub>	Turn – Off Delay Time				25.5		1
t <sub>f</sub>	Fall Time				4.0		1

# ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

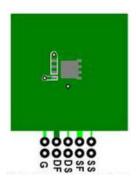
Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
DRAIN-SOUR	DRAIN-SOURCE DIODE CHARACTERISTICS						
V <sub>SD</sub>	Forward Diode Voltage	V 0VI 25 A	T <sub>J</sub> = 25°C		0.869		V
		$V_{GS} = 0 \text{ V, } I_{S} = 35 \text{ A}$	T <sub>J</sub> = 125°C		0.725		
t <sub>RR</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt = 300 A/μs, I <sub>S</sub> = 35 A			48.8		ns
Q <sub>RR</sub>	Reverse Recovery Charge				227		nC
t <sub>RR</sub>	Reverse Recovery Time	$V_{GS}$ = 0 V, $dI_S/dt$ = 1000 A/ $\mu$ s, $I_S$ = 35 A			36.4		ns
$Q_{RR}$	Reverse Recovery Charge				407		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

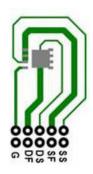
3. Switching characteristics are independent of operating junction temperatures.

#### NOTES:

4.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta CA}$  is determined by the user's board design.



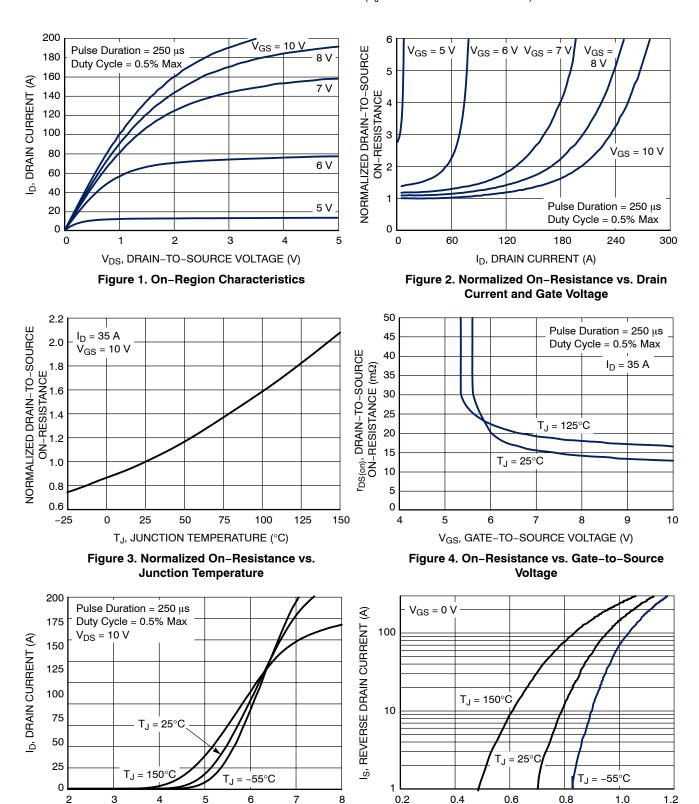
a) 46°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



b) 116°C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.</li>
   E<sub>AS</sub> of 196 mJ is based on starting T<sub>J</sub> = 25°C; L = 3 mH, I<sub>AS</sub> = 12.7 A, V<sub>DD</sub> = 100 V, V<sub>GS</sub> = 15 V. 100% tested at L = 0.1 mH, I<sub>AS</sub> = 41 A.
   Pulsed I<sub>D</sub> please refer to Fig 11 SOA graph for more details.
   Compute Continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

# TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted.)



V<sub>SD</sub>, BODY DIODE FORWARD VOLTAGE (V)

Figure 6. Source-to-Drain Diode Forward Voltage vs. Source Current

V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Figure 5. Transfer Characteristics

# **TYPICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted.)

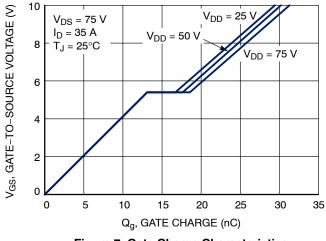


Figure 7. Gate Charge Characteristics

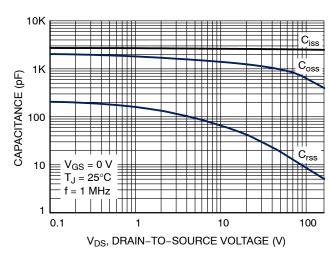


Figure 8. Capacitance vs. Drain-to-Source Voltage

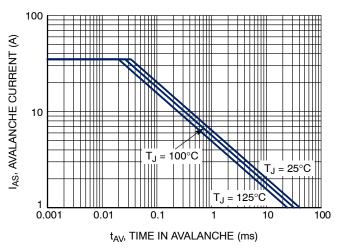


Figure 9. Unclamped Inductive Switching Capability

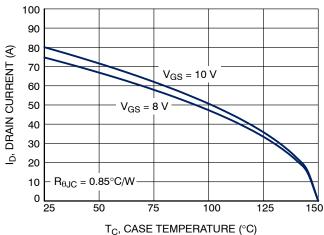


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

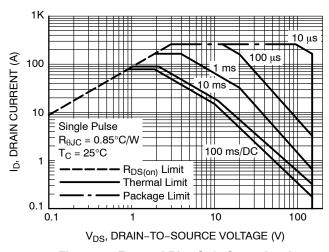


Figure 11. Forward Bias Safe Operating Area

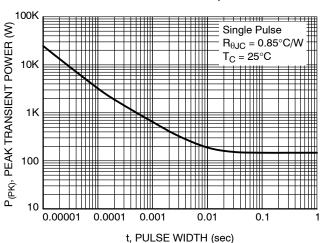


Figure 12. Single Pulse Maximum Power Dissipation

# TYPICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted.)

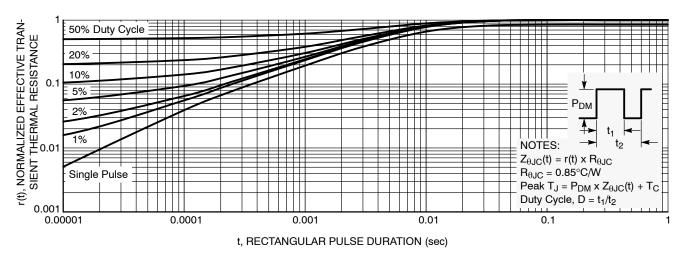


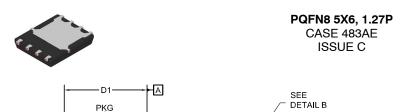
Figure 13. Junction-to-Case Transient Thermal Response Curve

PKG &

PIN 1

**AREA** 



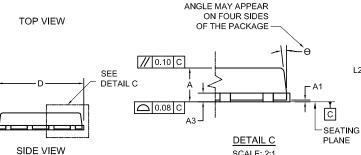


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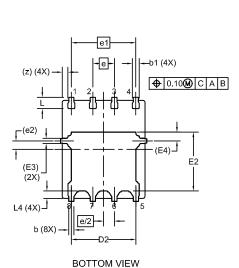
#### NOTES:

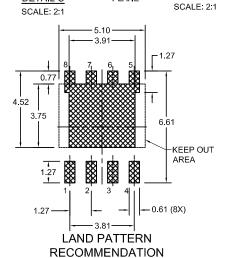
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.



OPTIONAL DRAFT

<del>ل</del> 22 **DETAIL B** 





#### \*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND

MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

MILLIMETERS			
MIN.	NOM.	MAX.	
0.90	1.00	1.10	
0.00	-	0.05	
0.21	0.31	0.41	
0.31	0.41	0.51	
0.15	0.25	0.35	
4.90	5.00	5.20	
4.80	4.90	5.00	
3.61	3.82	3.96	
5.90	6.15	6.25	
5.70	5.80	5.90	
3.38	3.48	3.78	
0.30 REF			
0.52 REF			
,	1.27 BSC	:	
Ū	0.635 BS	С	
3.81 BSC			
0.50 REF			
0.51	0.66	0.76	
0.05	0.18	0.30	
0.34	0.44	0.54	
0.34 REF			
0°	-	12°	
	MIN. 0.90 0.00 0.21 0.31 0.15 4.90 4.80 3.61 5.90 5.70 3.38	MIN. NOM. 0.90 1.00 0.00 - 0.21 0.31 0.31 0.41 0.15 0.25 4.90 5.00 4.80 4.90 3.61 3.82 5.90 6.15 5.70 5.80 3.38 3.48 0.30 REF 0.52 REF 1.27 BSC 0.635 BS 3.81 BSC 0.50 REF 0.51 0.66 0.05 0.18 0.34 0.44	

MILLIMETERS

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